

Search Notes**Application/Control No.**

10/590,482

Examiner

LEE NGUYEN

Applicant(s)/Patent under Reexamination

NISHIO ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	101 63.1 63.4	11/17/2007	LN
	67.11		
	67.13		
	67.15		
	277.1		
	277.2		
375	267		
	299		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB; USPAT; EPO; JPO; DERWENT) SEE SEARCH HISTORY	11/17/2007	LN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner